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| (PTO-1449) FILING DATE July 25, 2003 U.S. PATENT DOCUMENTS EXAMINER'S INITIALS CITE NO. US US US US US US US US US U | |
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| EXAMINER'S Foreign Patent Document Publication Date Name of Patentee or Pages, Columns, Lines Transl | |
| NITIALS CITE Country Codes -Number 4-Kind MM-DD-YYYY Applicant of Cited Document Figures Appear | |
| Yes | No |
| JP 62-257698 11/10/1987 TANAKA, et al. abstract | |
| JP 7-161840 06/23/1995 SASAKI abstract | |
| JP 6-291281 10/18/1994 MANO abstract | |
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| NAIKI, et al. "Center Wordline Cell: A New Symmetric Layout Cell for 64Mb SRAM" International Electron Devices Meeting Technical Digest, Washington, D.C. (December 5-8, 1993) pp. 33.3.1-33.3.4. | |
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